## Notice of References Cited Application/Control No. 10/651,387 Applicant(s)/Patent Under Reexamination HAMILTON, KEN Examiner Tan Dean D. Nguyen Applicant(s)/Patent Under Reexamination HAMILTON, KEN Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	"Excellence for Service Level, Change and Risk Management". Item no. 16 of IDS submitted by applicant on 1/12/04
*	\ \	Fenton, N. "Making Decisions: Bayesian Nets & MCDA", April 4, 2000, Computer Science Dept., London, pages 1-27
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.